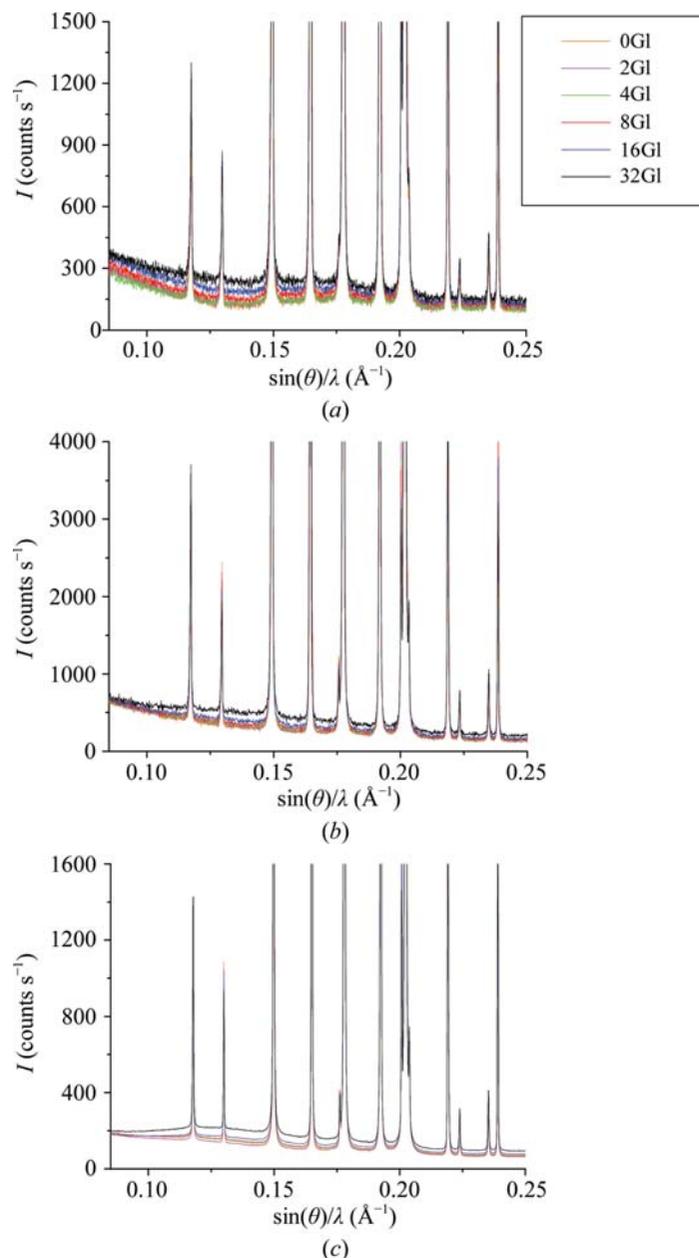


## 3.10. ACCURACY IN RIETVELD QUANTITATIVE PHASE ANALYSIS

**Figure 3.10.8**

Raw powder patterns for the amorphous-material-containing series composed of a constant matrix of calcite and zincite, and increasing amounts of ground glass. Quartz was added as internal standard. (a) Mo  $K\alpha_1$ , (b) Cu  $K\alpha_1$  and (c) SXRPD radiations. The intensities of the patterns have been rescaled to highlight the contributions of the glass to the background.

be pointed out that for the Mo  $K\alpha_1$  analyses the value from the measurement of the GI-free sample, 3.5 wt%, matches the value from the  $y$  intercept of the plot, 3.7 wt%, very well. Meanwhile, there is a much larger discrepancy for the similar Cu-based analyses, 12.0 and 10.0 wt%, respectively, which is quite far from zero. Hence, it is concluded that the amorphous contents derived from Mo  $K\alpha_1$  data are more accurate than those derived from Cu  $K\alpha_1$  data. However, it is not possible to reliably quantify amorphous contents below  $\sim 8$ –10 wt% from Mo  $K\alpha_1$  and Cu  $K\alpha_1$  diffraction data (see Table 3.10.4) with the internal-standard method.

On the contrary, SXRPD reliably allows quantification of amorphous contents down to  $\sim 2$  wt% for this relatively simple mixture. In addition, the AKLD and the KLD values reported in Table 3.10.4 demonstrate that the synchrotron analyses are indeed much better than the laboratory analyses.

**3.10.10. Conclusions**

- (i) We have thoroughly studied the limit of detection for a well crystallized inorganic phase in an inorganic compound matrix. We have determined the following LoDs for insoluble anhydrite:  $\sim 0.2$  wt%,  $\sim 0.3$  wt% and lower than 0.1 wt% for Cu  $K\alpha_1$ , Mo  $K\alpha_1$  and synchrotron radiations, respectively. We conclude that the LoD is slightly better for Cu  $K\alpha_1$  than for Mo  $K\alpha_1$  because the  $\lambda^3$  dependence of the diffraction intensity, with similar acquisition times, yielded slightly better signal-to-noise ratios in the Cu patterns. Of course, detector efficiencies also play a role in the measured signal-to-noise ratios.
- (ii) We have also studied the limit of quantification for a well crystallized inorganic phase using laboratory X-ray powder diffraction. This phase could be quantified at the level of 0.12 wt% in stable fits with repeatable outputs and good precision. However, the accuracy of these analyses was quite poor, with relative errors close to 100%. Only contents higher than 1.0 wt% yielded analyses with relative errors lower than 20%.
- (iii) The Rietveld quantitative phase analysis results from high-resolution Mo  $K\alpha_1$  powder diffraction (transmission geometry) and high-resolution Cu  $K\alpha_1$  powder diffraction (reflection geometry) were quite similar for a series of crystalline inorganic phase samples. We inferred the validation of the Mo-based analyses procedure from this initial study, as it yielded results very close to well established high-resolution Cu radiation analyses (see Fig. 3.10.7a). From the comparison of the AKLD values for the two types of analyses, it was demonstrated that the Mo  $K\alpha_1$  analyses were slightly better than those using Cu  $K\alpha_1$ .
- (iv) Comparison of the results obtained from Mo-based and Cu-based patterns for a series of crystalline organic phase mixtures showed that the Mo  $K\alpha_1$  analyses gave slightly more accurate values. This conclusion was drawn because the calibration curve obtained from Mo patterns with increasing content of xylose gave an  $R^2$  value closer to 1.0, a slope closer to 1.0 and an intercept value close to 0.0 (see Fig. 3.10.7b). The slightly poorer results from Cu  $K\alpha_1$  analyses are very likely to be due to the transparency effects in reflection geometry.
- (v) Comparison of the results obtained from Mo  $K\alpha_1$  and Cu  $K\alpha_1$  patterns for a series containing increasing amounts of amorphous glass also indicated that the Mo-based analyses were slightly more accurate than the corresponding Cu  $K\alpha_1$  analyses. This conclusion was drawn because the obtained calibration curve from the Mo data has (1) a slope closer to 1.0, (2) a smaller amorphous value for the glass-free sample and (3) a closer agreement between the intercept from the least-squares fit and the determined amorphous value for the glass-free sample (see Fig. 3.10.7c). The AKLD analysis confirmed this outcome. Furthermore, the results from synchrotron data have the best accuracy, as shown by the calibration plot and the AKLD analysis.

Finally, we conclude that for the challenging quantification analyses studied here, the results derived from high-energy Mo  $K\alpha_1$  patterns were slightly more accurate than those obtained from Cu  $K\alpha_1$  patterns. We justify this conclusion based on the larger tested volume for Mo  $K\alpha_1$  analyses, which led to better statistics/accuracy in the recorded powder-pattern intensities. The minimization of microabsorption in the Mo  $K\alpha_1$  transmission